SPECIFICATION

SPEC. No. A-ESD-b

D A T E: 2014 May.

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS

CGA Series / Automotive Grade

ESD Protection CGA3EA Series

Please return this specification to TDK representatives.

If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation
Sales
Electronic Components
Sales & Marketing Group

TDK-EPC Corporation
Engineering

Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan,

TDK (Suzhou) Co., Ltd and TDK Components U.S.A. Inc.

EXPLANATORY NOTE:

This specification warrants the quality of the ceramic chip capacitor. The chips should be evaluated or confirmed a state of mounted on your product.

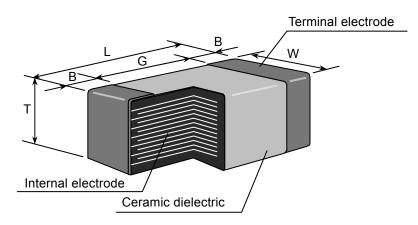
If the use of the chips go beyond the bounds of this specification, we can not afford to guarantee.

2. CODE CONSTRUCTION

(Example)

Catalog Number : (Web)	<u>CGA3</u> (1)	<u>E</u> (2)	<u>A</u> (3)	<u>C0G</u> (4)	<u>2 A</u> (5)	<u>103</u> (6)	<u>J</u> (7)	0 <u>80</u> (8)	<u>A</u> (9)	<u>C</u> (10)
Item Description :	CGA3	<u>E</u> (2)	<u>A</u>	<u>C0G</u>	2 A (5)	<u>103</u> (6)	<u>J</u> (7)	<u>T</u> (11)	<u>xxxx</u> (12)	

(1) Type



Please refer to product list for the dimension of each product.

(2) Thickness

* As for dimension tolerance, please contact with our sales representative.

Thickness	Dimension (mm)
Е	0.80

(3) Identification for ESD capacitor (Details are shown in table 1 No.16 at page 6)

Symbol	Identification
Α	ESD Capacitor

(4) Temperature Characteristics (Details are shown in table 1 No.6 at page 3)



(5) Rated Voltage

Symbol	Rated Voltage
2 A	DC 100 V

(6) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

Example 103 \rightarrow 10,000pF

(7) Capacitance tolerance

Symbol	Tolerance		
J	± 5%		

(8) Thickness code (Only Catalog Number)

(9) Package code (Only Catalog Number)

(10) Special code (Only Catalog Number)

(11) Packaging (Only Item Description)

(Bulk is not applicable for CGA1 and CGA2 type.)

Symbol	Packaging
В	Bulk
Т	Taping

(12) Internal code (Only Item Description)

3. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature	
C0G	-55°C	125°C	25°C	
NP0	-55°C	150°C	25°C	

4. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

5. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.



6. PERFORMANCE

table 1

No.	Item	Performance	Test or inspection method		
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3×).		
2	Insulation Resistance	10,000MΩ min.	Apply rated voltage for 60s.		
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.	3 times of rated voltage Above DC voltage shall be applied for 1 to 5s. Charge / discharge current shall not exceed 50mA.		
4	Capacitance	Within the specified tolerance.	Capacitance Measuring Measuring frequency voltage		
			0.5-5 Vms. Over 1000pF		
			For information which product has which measuring voltage, please contact with our sales representative.		
5	Q (Class1)	1,000 min.	See No.4 in this table for measuring condition.		
6	Temperature Characteristics of Capacitance (Class1)	T.C. Temperature Coefficient COG 0 ± 30 (ppm/°C) NP0 0 ± 30 (ppm/°C) Capacitance drift within ± 0.2% or ± 0.05pF, whichever larger.	Temperature coefficient shall be calculated based on values at 25°C and 85°C temperature. Measuring temperature below 20°C shall be -10°C and -25°C.		
7	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b and apply a pushing force of 17.7N with 10±1s. Pushing force Capacitor P.C.Board		



(continued)

No.	It	em	Perfo	ormance	Test or inspection method
8	8 Bending		No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 2a or Appendix 2b and bend it for 2mm. 50 F R230 (Unit : mm)
9 Solderability			termination. 25% may have spots but not co spot. Ceramic surface shall not be exp		Completely soak both terminations in solder at 235±5°C for 2±0.5s. Solder: H63A (JIS Z 3282) Flux: Isopropyl alcohol (JIS K 8839) Rosin(JIS K 5902) 25% solid solution.
to solder ap		External appearance Capacitance	No cracks are a terminations shall least 60% with a Characteristics Cog NP0	all be covered at	Completely soak both terminations in solder at 260±5°C for 5±1s. Preheating condition Temp.: 150±10°C Time: 1 to 2min. Flux: Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid
	Q (Class1) Insulation Resistance Voltage proof		1,000 min. Meet the initial	spec.	solution. Solder: H63A (JIS Z 3282) Leave the capacitors in ambient
			No insulation breakdown or other damage.		condition for 6 to 24h (Class1) before measurement.

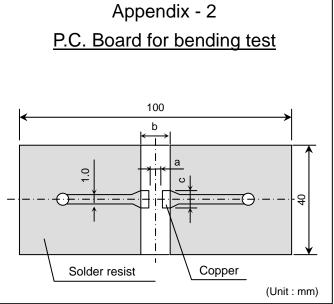
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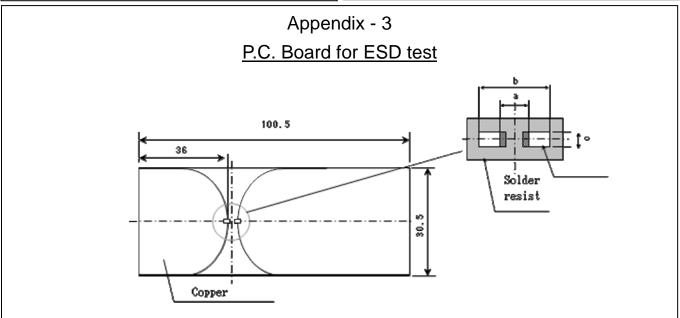
No.	Ito	em	Perfo	ormance		Test or inspection method		
11 Vibration		Vibration External appearance Capacitance		Change from the value before test ± 2.5%	P.C.Botel	Reflow solder the capacitors on a P.C.Board shown in Appendix1 before testing. Vibrate the capacitor with following conditions.		
		Q (Class1)	1,000 min.		Applied force: 5G max. Frequency: 10-2000Hz Duration: 20 min. Cycle: 12 cycles in each 3 mutually perpendicular directions.			
	Temperature cycle	External appearance	No mechanical damage.		Reflov P.C.B	v solder the capacitors pard shown in Appendindix 1b before testing.		
		Capacitance	Characteristics COG NP0	Change from the value before test ± 2.5%	Expose the capacitors in the step1 through step 4 and retimes consecutively.		e condition	
		Q (Class1)	1,000 min. condition for 6 to measurement. Meet the initial spec.		the capacitors in amb ion for 6 to 24h (Class urement.			
		Insulation Resistance			Step	Temperature(°C)	Time (min.	
		Voltage proof	No insulation breakdown or other damage.		1	Min. operating temp. ±3	30 ± 3	
		proor.			2	Reference Temp. ±2	2 - 5	
					3	Max. operating temp. ±2	30 ± 2	
					4	Reference Temp. ±2	2 - 5	
13	Moisture Resistance	External appearance	No mechanical	damage.	Reflow solder the capacito P.C.Board shown in Appen			
	(Steady State)	Capacitance	Characteristics	Change from the value before test	Apper	ndix 1b before testing.		
			COG NP0	± 7.5%	Leave at temperature 40±2°C, 90 95%RH for 500 +24,0h.		C, 90 to	
		Q (Class1)	350 min.			the capacitors in amb		
		Insulation Resistance	1,000MΩ min.			urement.	i) belole	

(continued)

No.	It	em	Performance		Test or inspection method
14	Moisture Resistance	External appearance Capacitance	No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.
			Characteristics	Change from the value before test	Apply the rated voltage at temperature 85°C and 85%RH for 1000 +24,0h.
			COG NP0	± 7.5%	Charge/discharge current shall not
		Q (Class1)	200 min.		exceed 50mA. Leave the capacitors in ambient
		Insulation Resistance	500M Ω min.		condition for 6 to 24h (Class1) before measurement
15	Life	External appearance	No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.
		Capacitance	Characteristics	Change from the value before test	Below the voltage shall be applied at
			COG NP0	± 7.5%	maximum operating temperature ±2°C for 1,000 +48, 0h.
		Q	350 min.		Applied voltage
		(Class1)	1,000MΩ min.		Rated voltage x2
		Insulation Resistance	T,000IVISZ IIIIII.		Rated voltage x1 For information which product has which applied voltage, please contact with our sales representative.
					Charge/discharge current shall not exceed 50mA.
					Leave the capacitors in ambient condition for 6 to 24h (Class1) before measurement.
16	ESD		Withstand ES insulation break	D voltage without down. Rd	Solder the capacitors on a P.C.Board shown in Appendix3 before testing.
			Voltage	Test	Circuit condition : IEC 61000-4-2 (Cs : 150pF / Rd : 330 Ω)
			Source Cs T specimen		Test method : Direct contact Number of ESD pulse : \pm 10 times
			Rc : Change curr Rd : Discharge re Cs : Energy stora	egistor	As for applied ESD level, please refer to the table A in the end of the specification.
			ESD gun		After each ESD pulse, dissipation of residual change shall be done with applying 1M Ω registance for 1 sec min.

Appendix - 1 P.C. Board for reliability test Solder resist Copper (Unit : mm)





Material: Glass Epoxy (As per JIS C6484 GE4)

P.C. Board thickness: Appendix-1, 2, 3 1.6mm

Copper (thickness 0.035mm)

Solder resist

Appendix 1, 2

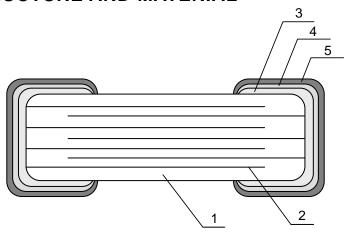
TDK (EIA atula)	Dimensions (mm)			
TDK (EIA style)	а	b	С	
CGA3 (CC0603)	1.0	3.0	1.2	

Appendix 3

TDK (EIA otylo)	Dimensions (mm)			
TDK (EIA style)	а	b	С	
CGA3 (CC0603)	1.0	3.0	0.75	

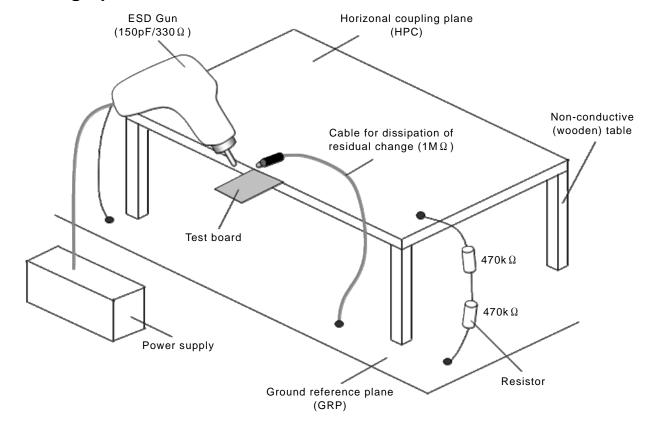


7. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL
1	Dielectric	CaZrO ₃
2	Electrode	Nickel (Ni)
3		Copper (Cu)
4	Termination	Nickel (Ni)
5		Tin (Sn)

8. Setting up for ESD test



9. Caution

No.	Process	Condition				
1	Operating Condition (Storage,	1-1. Storage1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt.				
	Transportation)	 The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur. 				
		3) Avoid storing in sun light and falling of dew.				
		4) Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.				
		5) Capacitors should be tested for the solderability when they are stored for long time.				
		1-2. Handling in transportation				
		In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 Handling in transportation)				
2	Circuit design Laution	2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.				
		1) Do not use capacitors above the maximum allowable operating temperature.				
		Surface temperature including self heating should be below maximum operating temperature.				
		(Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C)				
		 The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration. Operating voltage Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. 				
		AC or pulse with overshooting, V_{P-P} must be below the rated voltage. (1) and (2)				
		When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.				
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage				
		Positional Measurement (Rated voltage) 0 V _{0-P} 0				
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)				
		Positional Measurement (Rated voltage)				



No.	Process	Condition				
2	Circuit design (Caution	 Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced. The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound. 				
3	Designing P.C.board	The amount of solder at the terminations has a direct effect on the reliability of the capacitors. 1) The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations. 2) Avoid using common solder land for multiple terminations and provide individual solder land for each terminations. 3) Size and recommended land dimensions. Chip capacitors Solder land Solder resist				
		Flow soldering (mm) Type CGA3 (CC0603) A 0.7 - 1.0 B 0.8 - 1.0 C 0.6 - 0.8 Reflow soldering (mm) Type CGA3 (CC0603) A 0.6 - 0.8 B 0.6 - 0.8 C 0.6 - 0.8				

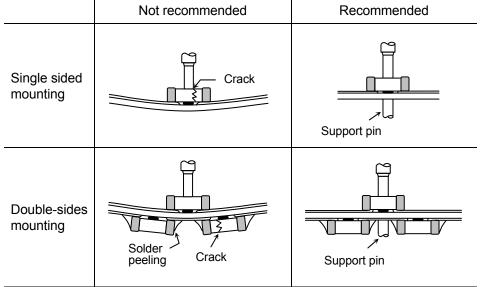
No.	Process		Condition				
3	Designing P.C.board	4) Recommend	4) Recommended chip capacitors layout is as following.				
			Disadvantage against bending stress	Advantage against bending stress			
		Mounting face	Perforation or slit	Perforation or slit			
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.			
		Chip arrangemer (Direction)	Mount perpendicularly to perforation or slit Perforation or slit	Mount in parallel with perforation or slit Perforation or slit			
		Distance fro slit	Closer to slit is higher stress $ \begin{pmatrix} \ell_1 & \ell_2 \end{pmatrix} $	Away from slit is less stress $\frac{\ell_2}{(\ell_1 < \ell_2)}$			

Condition No. **Process** 3 5) Mechanical stress varies according to location of chip capacitors on the P.C.board. Designing P.C.board E Perforation 00000 00000 В Slit The stress in capacitors is in the following order. A > B = C > D > E6) Layout recommendation Use of common Use of common Soldering with Example solder land with solder land chassis other SMD Lead wire Chassis Solder Excessive solder land chip Solder Need to avoid Excessive solder PCB Adhesive Solder land Missing Solder land solder Lead wire Solder resist Solder resist Recommendation

Solder resist

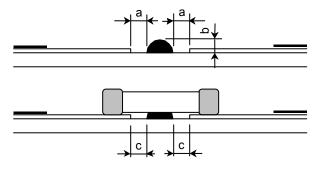
 $\ell^2 > \ell^1$

No.	Process		Condition				
4	Mounting	capacitors to result of the surface and not consider the mount of the surface and not consider the surface and su	read is adjusted too low, it may in all in cracking. Please take following the dead center of the mounting here press it. Inting head pressure to be 1 to 3N impact energy from mounting here bottom side of the P.C.board.	ead to reach on the P.C.board of static weight.			
			Not recommended	Recommended			

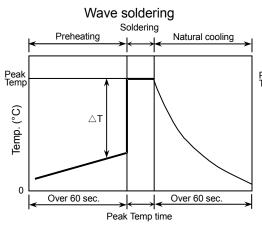


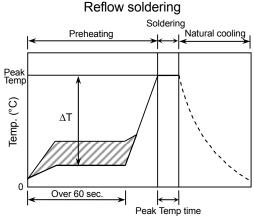
When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.

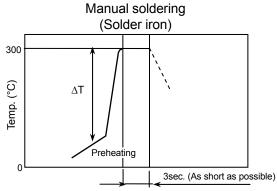
4-2. Amount of adhesive



No.	Process	Condition			
activity may also degrade the insula degradation, it is recommended follows:		5-1. Flux selection Although highly-activated flux gives better sactivity may also degrade the insulation of the degradation, it is recommended following.	•		
		It is recommended to use a mildly activa Strong flux is not recommended.	ted rosin flux (less than 0.1wt% chlorine).		
		2) Excessive flux must be avoided. Please provide proper amount of flux.			
vave coldening		washing is necessary.			
		5-2. Recommended soldering profile by vario	us methods		
		Wave soldering	Reflow soldering		







5-3. Recommended soldering peak temp and peak temp duration

Temp./Duration	Wave soldering		Reflow soldering	
Solder	Peak temp(°C)	Duration(sec.)	Peak temp(°C)	Duration(sec.)
Pb-Sn Solder	250 max.	3 max.	230 max.	20 max.
Lead Free Solder	260 max.	5 max.	260 max.	10 max.

Recommended solder compositions

Sn-37Pb (Pb-Sn solder)

Sn-3.0Ag-0.5Cu (Lead Free Solder)



No.	Process			Condition			
5	Soldering	5-4. Avoiding thermal sh	hock				
		1) Preheating condition	n				
		Soldering	g	Туре	Temp. (°C)		
		Wave solde	ering CC	GA3(CC0603)	ΔT ≤ 150		
		Reflow solds	ering CC	GA3(CC0603)	ΔT ≤ 150		
		Manual solde	ering CC	GA3(CC0603)	ΔT ≤ 150		
		 Cooling condition Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (ΔT) must be less than 100°C. 5-5. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board. 					
		Excessive solder			Higher tensile force in chip capacitors to cause crack		
		Adequate =			ximum amount nimum amount		
		Insufficient solder ==			Low robustness may cause contact failure or chip capacitors come off the P.C.board.		
		land size. The high heat shock may ca Please make sure time in accordance	dering iron to f solder iron her the tip to ause a crac the tip tem e with follow	varies by its type, P.C emperature, the quicke k in the chip capacitors p. before soldering and	d keep the peak temp and ndition. (Please preheat the		

No.	Process	Condition					
5	Soldering	Recommended solder iron condition (Pb-Sn Solder and Lead Free Solder)					
		Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)		
		300 max.	3 max.	20 max.	Ø 3.0 max.		
		Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.					
		5-7. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder.					
		soldering.	een the mounted p nized. The tombouted (in longitudinal of 335B Annex A (Info	stone phenomeno direction) in the sar			
Cleaning I) If an unsuitable cleaning fluid is used, flux residue or some foreign a stick to chip capacitors surface to deteriorate especially the insulation. 2) If cleaning condition is not suitable, it may damage the chip capacitors.				e insulation resistance.			
2)-1. Insufficient washing (1) Terminal electrodes may corrode by Halogen in the flux. (2) Halogen in the flux may adhere on the surface of capa the insulation resistance.							
		(3) Water soluble fluoring problems (1) and	_	endency to have	e above mentioned		
		2)-2. Excessive washing					
		When ultrasonic c	nection between the	ne ceramic chip ca	rasonic energy output apacitor's body and the nmended condition.		
			Power: 20 W/l r Frequency: 40 k Washing time: 5	Hz max.			
		2)-3. If the cleaning fluid is bring the same result			ncreases, and it may		

No.	Process		Condition			
7	Coating and molding of the P.C.board	 When the P.C.board is coated, please verify the quality influence on the product. Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors. Please verify the curing temperature. 				
8	Handling after chip mounted	2) When fur to be adjusted bence	Twist Twist Derformed, check pin pressure tends act. But if the pressure is excessive p capacitors or peel the terminations the P.C.board.			
		Item Board bending	Not recommended Termination peeling Check pin	Support pin Check pin		
9	Handling of loose chip capacitors	Check nin				

-		<u> </u>
No.	Process	Condition
10	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.
11	Others Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (electric trains, ships, etc.) (3) Medical equipment (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.



10. PACKAGING LABEL

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F}$$
 $\underline{2}$ \underline{A} - \underline{OO} - \underline{OOO} (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

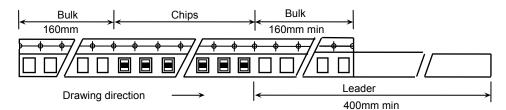
11. BULK PACKAGING QUANTITY

Total number of components in a plastic bag for bulk packaging: 1,000pcs.

12. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

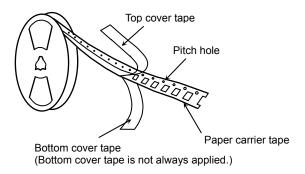
- 1-1. Dimensions of carrier tape
 Dimensions of paper tape shall be according to Appendix 4.
- 1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 5. Dimensions of Ø330 reel shall be according to Appendix 6.

1-4. Structure of taping



2. CHIP QUANTITY

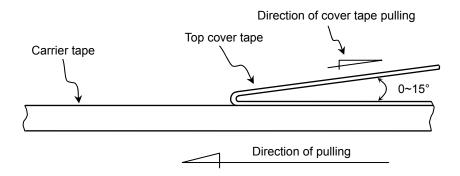
Type	Thickness	Taping	Chip quantity(pcs.)		
туре	of chip	Material	Ø 178mm reel	Ø 330mm reel	
CGA3(CC0603)	0.80 mm	Paper	4,000	10,000	



3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05-0.7N. (See the following figure.)

TYPE 1 (Paper)

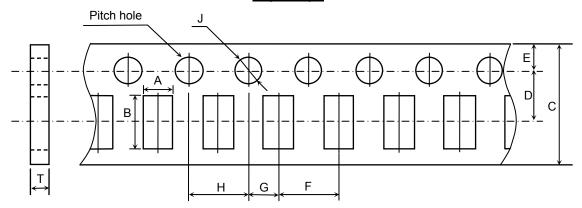


- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.



Appendix 4

Paper Tape

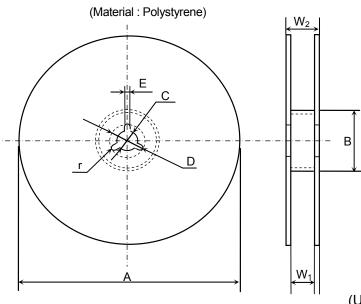


(Unit:mm)

Symbol Type	А	В	С	D	E	F
CGA3 (CC0603)	(1.10)	(1.90)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
Symbol Type	G	Н	J	Т		
CGA3 (CC0603)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 ^{+0.10}	1.20 max.		

^{*} The values in the parentheses () are for reference.

Appendix 5

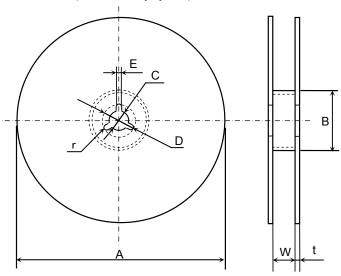


	•			,	(1	Unit: mm)
Symbol	А	В	С	D	Е	W ₁
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W_2	r
Dimension	13.0 ± 1.4	1.0

Appendix 6

(Material : Polystyrene)



	ľ				$\longleftrightarrow \mid \longleftarrow$	(Unit:mm)
Symbol	Α	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0